


|  |  |  |
|--|--|--|
| <b>Search Notes</b><br><br> | <b>Application/Control No.</b><br><br>10589259 | <b>Applicant(s)/Patent Under Reexamination</b><br><br>KOBAYASHI ET AL. |
|  | <b>Examiner</b><br><br>Louisa Lao              | <b>Art Unit</b><br><br>1621  |

| SEARCHED |          |      |          |
|----------|----------|------|----------|
| Class    | Subclass | Date | Examiner |
|          |          |      |          |

| SEARCH NOTES  |         |          |
|---|---------|----------|
| Search Notes  | Date    | Examiner |
| EAST- USPAT USPGPub DERWENT EPO JPO + inventor + text + class/subclass                        | 6/23/08 | mll      |
| STN- structure, NPL via HCAPI for inventor, text  | 6/24/08 | mll      |
| STIC STN search - see eDAN  | 6/24/08 | mll      |
| IDS reviewed, foreign patent equivalents + cited references therein; PALM for inventors' work | 6/23/08 | mll      |

| INTERFERENCE SEARCH |          |      |          |
|---------------------|----------|------|----------|
| Class               | Subclass | Date | Examiner |
|                     |          |      |          |

|  |  |
|--|--|
|  |  |
|--|--|